Application/Control No. Applicant(s)/Patent Under Reexamination TANIMOTO ET AL. Examiner Takisha Miller Applicant(s)/Patent Under Reexamination TANIMOTO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,631,415	05-1997	Igarashi et al.	73/202.5
*	В	US-5,537,870	07-1996	Zurek et al.	73/202
*	C.	US-5,942,683	08-1999	Aoi et al.	73/202.5
*	D	US-5,696,321	12-1997	Igarashi et al.	73/202.5
*	Е	US-6,751,621	06-2004	Calistri-Yeh et al.	707/100
*	F	US-6,474,177	11-2002	Maeda et al.	73/861.63
*	G	US-5,804,718	09-1998	Nagasaka et al.	73/202
*	Н	US-6,220,090	04-2001	Kohno et al.	73/202
*	١,	US-6,526,822	03-2003	Maeda et al.	73/204.21
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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